

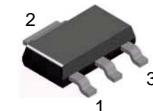
## HFT1N60F 600V N-Channel MOSFET

### FEATURES

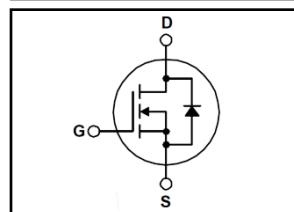
- Originative New Design
- Superior Avalanche Rugged Technology
- Robust Gate Oxide Technology
- Very Low Intrinsic Capacitances
- Excellent Switching Characteristics
- Unrivalled Gate Charge : 3.7 nC (Typ.)
- Extended Safe Operating Area
- Lower  $R_{DS(ON)}$  : 6.5 Ω (Typ.) @ $V_{GS}=10V$
- 100% Avalanche Tested

$BV_{DSS} = 600 V$   
 $R_{DS(on)\ typ} = 6.5 \Omega$   
 $I_D = 1 A$

**SOT-223**



1.Gate 2. Drain 3. Source



### Absolute Maximum Ratings $T_C=25^\circ C$ unless otherwise specified

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	600	V
$I_D$	Drain Current – Continuous ( $T_C = 25^\circ C$ )	1 *	A
	Drain Current – Continuous ( $T_C = 100^\circ C$ )	0.6 *	A
$I_{DM}$	Drain Current – Pulsed (Note 1)	4 *	A
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	33	mJ
$I_{AR}$	Avalanche Current (Note 1)	1	A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	0.2	mJ
$P_D$	Power Dissipation ( $T_C = 25^\circ C$ )	2.1	W
	- Derate above $25^\circ C$	0.02	W/ $^\circ C$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ C$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ C$

\* Drain current limited by maximum junction temperature

### Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient *	--	60	$^\circ C/W$

\* When mounted on the minimum pad size recommended (PCB Mount)

**Electrical Characteristics**  $T_J=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
--------	-----------	-----------------	-----	-----	-----	-------

**On Characteristics**

$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.0	--	4.0	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 0.5 \text{ A}$	--	6.5	8	$\Omega$

**Off Characteristics**

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	600	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 600 \text{ V}$ , $V_{GS} = 0 \text{ V}$	--	--	10	$\mu\text{A}$
		$V_{DS} = 480 \text{ V}$ , $T_C = 125^\circ\text{C}$	--	--	100	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 30 \text{ V}$ , $V_{DS} = 0 \text{ V}$	--	--	$\pm 100$	nA

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS} = 25 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$	--	160	--	pF
$C_{oss}$	Output Capacitance		--	26	--	pF
$C_{rss}$	Reverse Transfer Capacitance		--	6.5	--	pF

**Switching Characteristics**

$t_{d(on)}$	Turn-On Time	$V_{DS} = 300 \text{ V}$ , $I_D = 1.0 \text{ A}$ , $R_G = 25 \Omega$ (Note 4,5)	--	13	--	ns
$t_r$	Turn-On Rise Time		--	17	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	19	--	ns
$t_f$	Turn-Off Fall Time		--	22	--	ns
$Q_g$	Total Gate Charge	$V_{DS} = 480 \text{ V}$ , $I_D = 1.0 \text{ A}$ , $V_{GS} = 10 \text{ V}$ (Note 4,5)	--	3.7	--	nC
$Q_{gs}$	Gate-Source Charge		--	0.9	--	nC
$Q_{gd}$	Gate-Drain Charge		--	1.3	--	nC

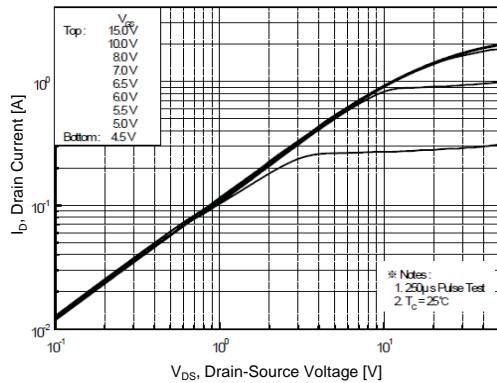
**Source-Drain Diode Maximum Ratings and Characteristics**

$I_S$	Continuous Source-Drain Diode Forward Current	--	--	1.0	A	
$I_{SM}$	Pulsed Source-Drain Diode Forward Current	--	--	4.0		
$V_{SD}$	Source-Drain Diode Forward Voltage	$I_S = 1.0 \text{ A}$ , $V_{GS} = 0 \text{ V}$	--	--	1.3	V
$trr$	Reverse Recovery Time	$I_S = 1.0 \text{ A}$ , $V_{GS} = 0 \text{ V}$ $dI/dt = 100 \text{ A}/\mu\text{s}$ (Note 4)	--	181	--	ns
$Qrr$	Reverse Recovery Charge		--	0.5	--	nC

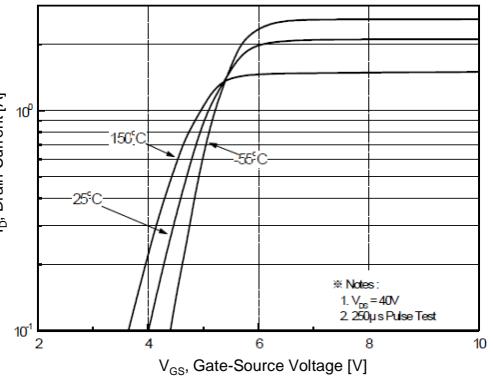
**Notes :**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $L=59\text{mH}$ ,  $I_{AS}=1.0\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- $I_{SD}\leq 1.0\text{A}$ ,  $di/dt\leq 200\text{A}/\mu\text{s}$ ,  $V_{DD}\leq BV_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

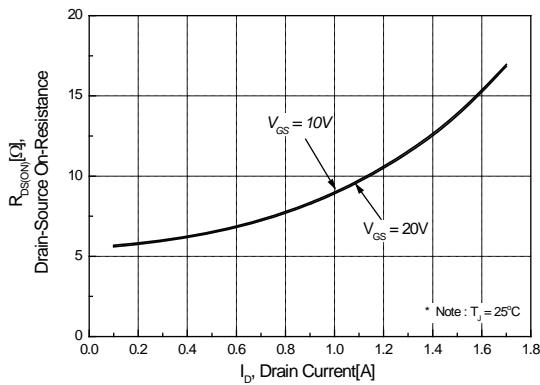
## Typical Characteristics



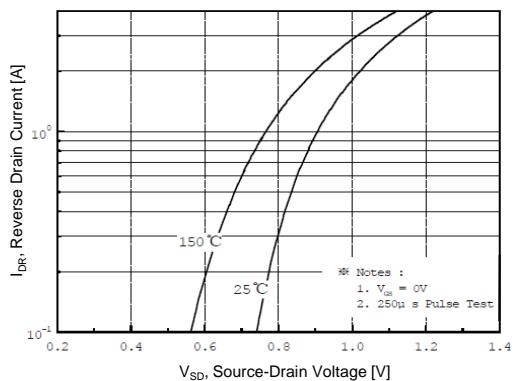
**Figure 1. On Region Characteristics**



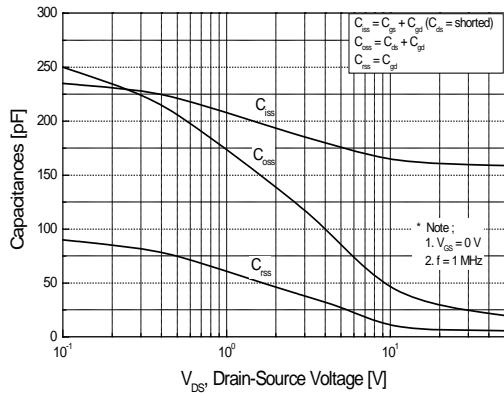
**Figure 2. Transfer Characteristics**



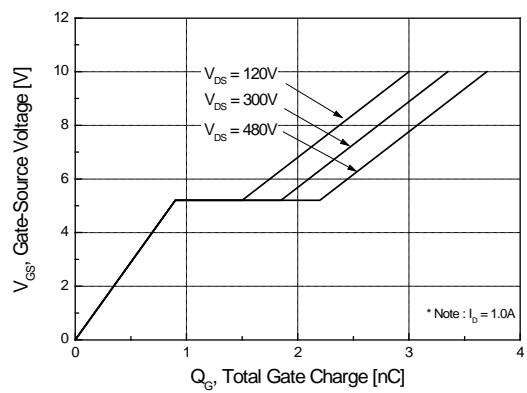
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

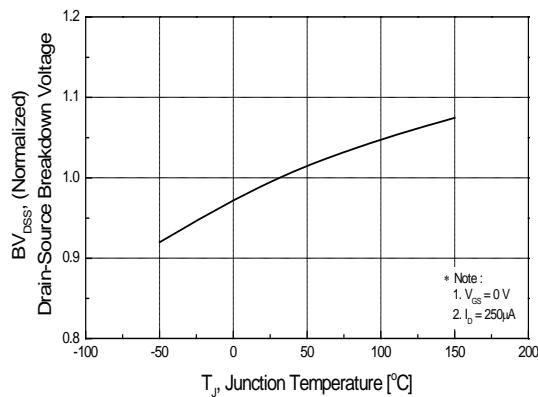


**Figure 5. Capacitance Characteristics**

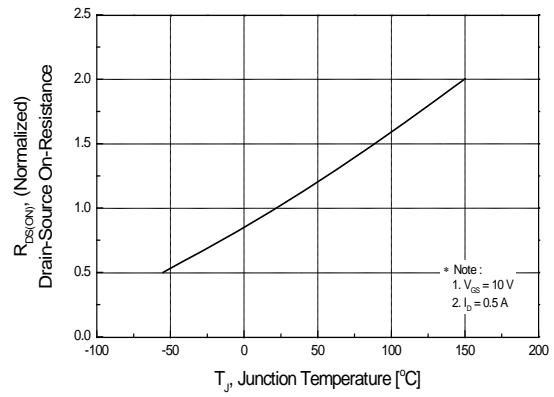


**Figure 6. Gate Charge Characteristics**

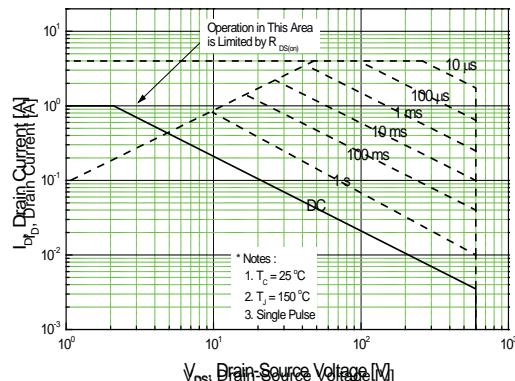
## Typical Characteristics (continued)



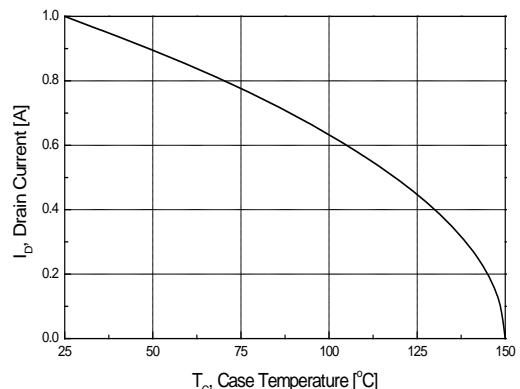
**Figure 7. Breakdown Voltage Variation vs Temperature**



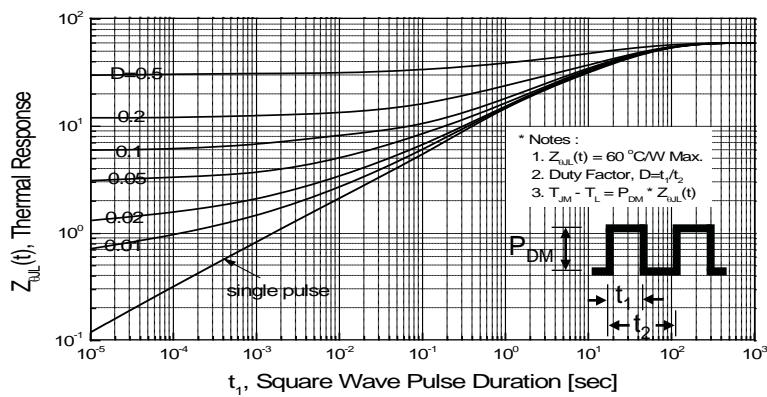
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs Case Temperature**



**Figure 11. Transient Thermal Response Curve**

Fig 12. Gate Charge Test Circuit &amp; Waveform

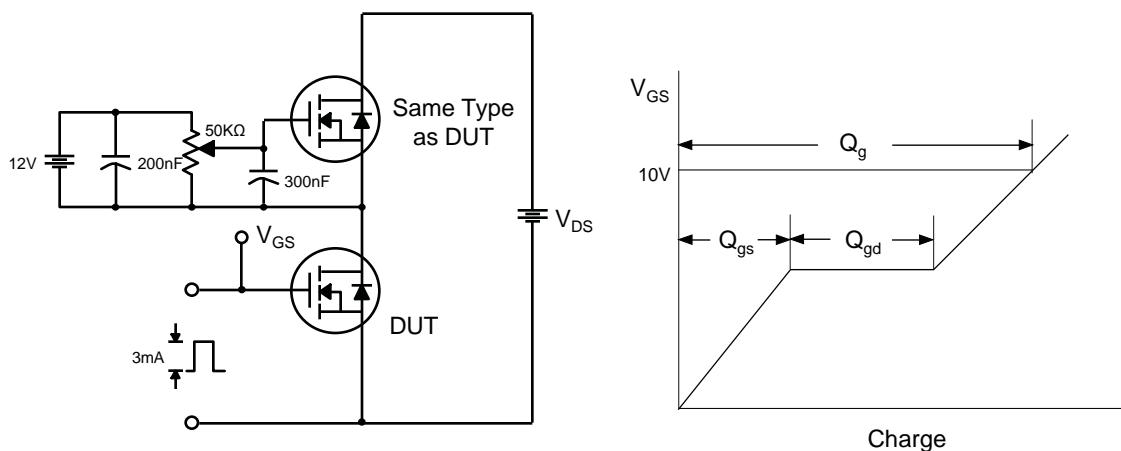


Fig 13. Resistive Switching Test Circuit &amp; Waveforms

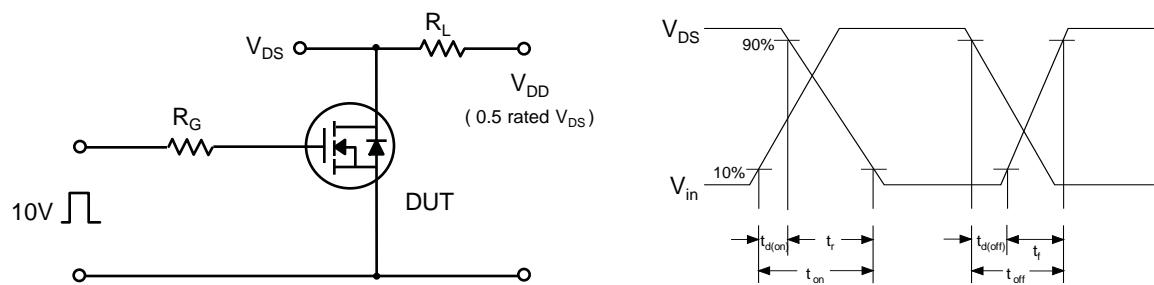


Fig 14. Unclamped Inductive Switching Test Circuit &amp; Waveforms

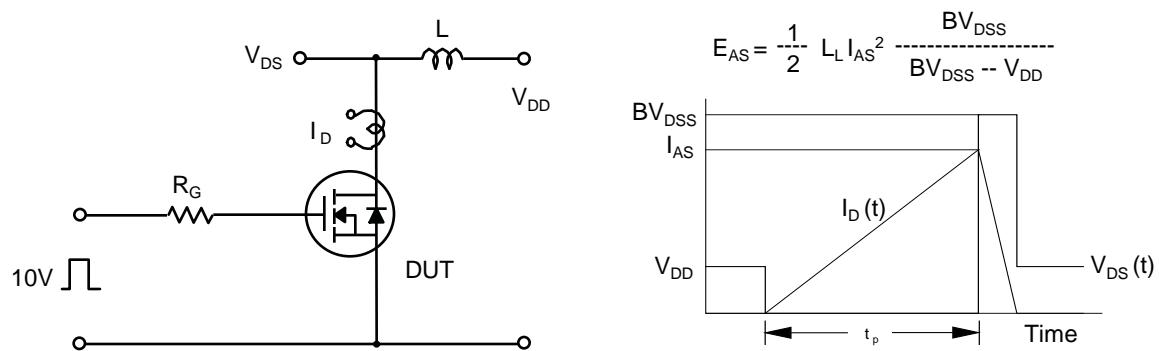
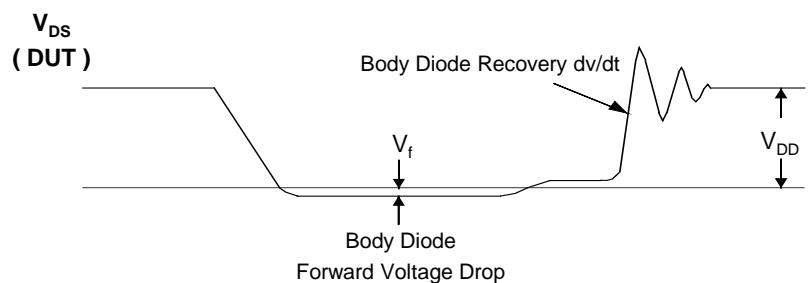
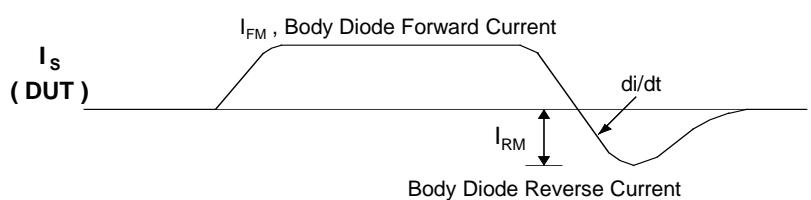
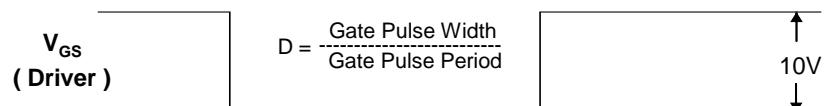
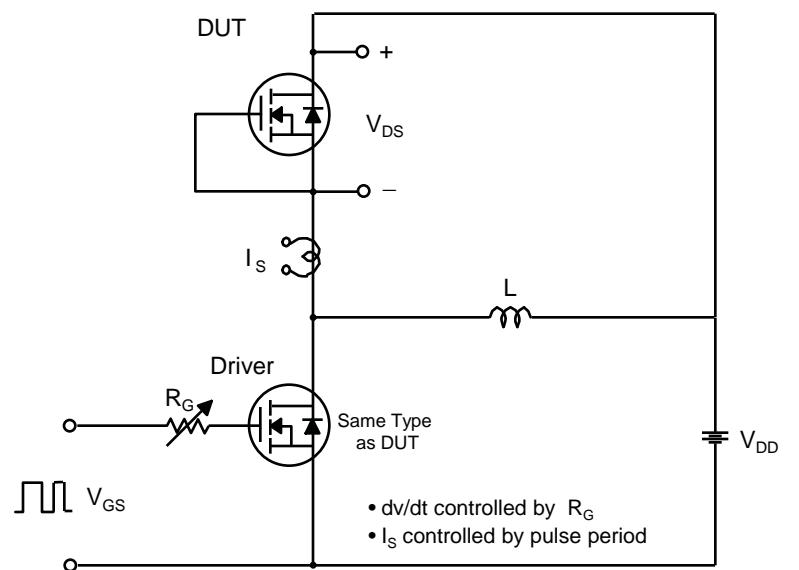
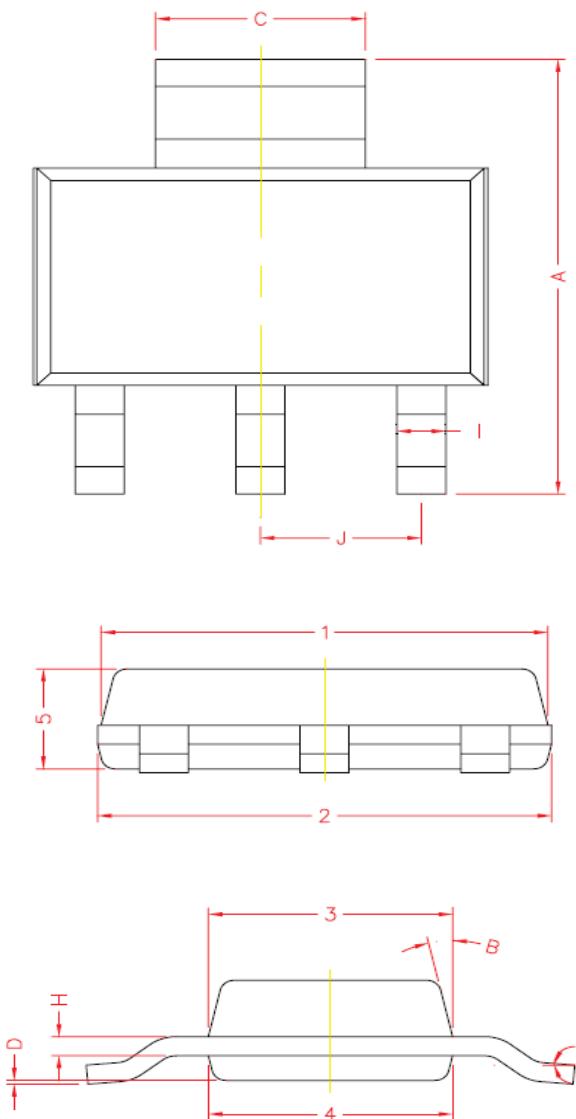


Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



**Package Dimension****SOT-223**

Symbol	Dimension [mm]	
	Reference	Tolerance
A	7	$\pm 0.3$
C	3	$\pm 0.1$
D	0.06	$\pm 0.04$
E	5°	$\pm 5^\circ$
I	0.7	$\pm 0.1$
H	0.3	$\pm 0.05$
B	13° TYP.	
J	2.3 REF.	
1	6.5	$\pm 0.2$
2	6.5	$\pm 0.2$
3	3.5	$\pm 0.2$
4	3.5	$\pm 0.2$
5	1.6	$\pm 0.2$